PRELIMINARY

Integrated Circuit Systems, Inc.

ICS8432-11
700MHz/350MHz, LOW PHASE NOISE,
CRYSTAL-TO- 3.3V LVPECL FREQUENCY SYNTHESIZER

## GENERAL DESCRIPTION

ICS HiPerClockS™

The ICS8432-11 is a general purpose, dual output Crystal-to-3.3V Differential LVPECL High Frequency Synthesizer and a member of the HiPerClockS™ family of High Performance Clock Solutions from ICS. The ICS8432-11 has a selectable TEST_CLK or crystal inputs. The TEST_CLK input accepts LVCMOS or LVTTL input levels and translates them to 3.3V LVPECL levels. The VCO operates at a frequency range of 200MHz to 700MHz. The VCO frequency is programmed in steps equal to the value of the input reference or crystal frequency. Output frequencies up to 700MHz for FOUT and 350MHz for FOUT/2 can be programmed using the serial or parallel interfaces to the configuration logic. The low phase noise characteristics and the multiple frequency outputs of the ICS8432-11 makes it an ideal clock source for Fiber Channel 1 and 2, and Infiniband applications.

FEATURES

- Dual differential 3.3V LVPECL outputs

- Selectable crystal oscillator interface or LVCMOS/LVTTL TEST_CLK

- TEST_CLK can accept the following input levels: LVCMOS or LVTTL

- Maximum FOUT frequency: 700MHz
- Maximum FOUT/2 frequency: 350MHz

- VCO range: 200MHz to 700MHz

- Parallel interface for programming counter and VCO frequency multiplier and dividers

- Cycle-to-cycle jitter: 25ps (maximum)

- RMS period jitter: TBD

- 3.3V supply voltage

- 0°C to 70°C ambient operating temperature

BLOCK DIAGRAM
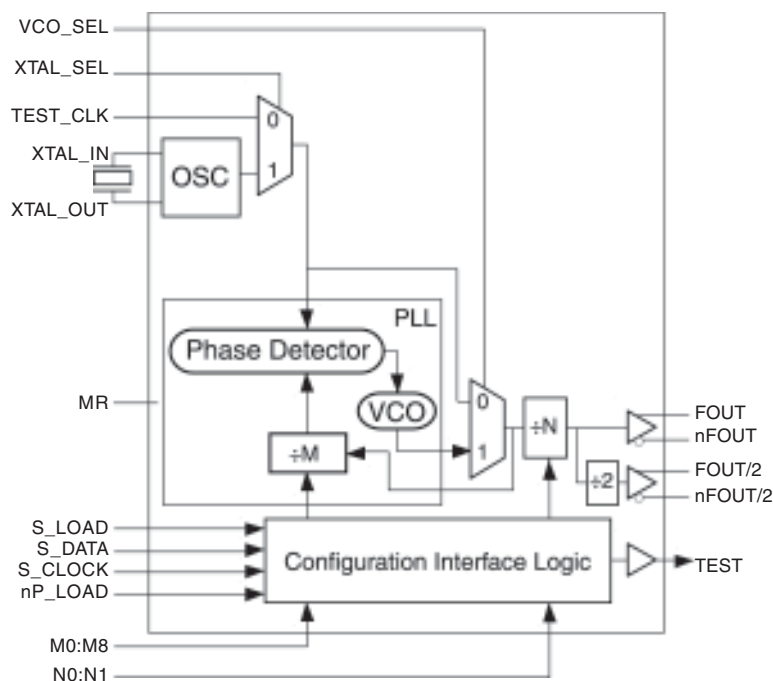
PIN ASSIGNMENT
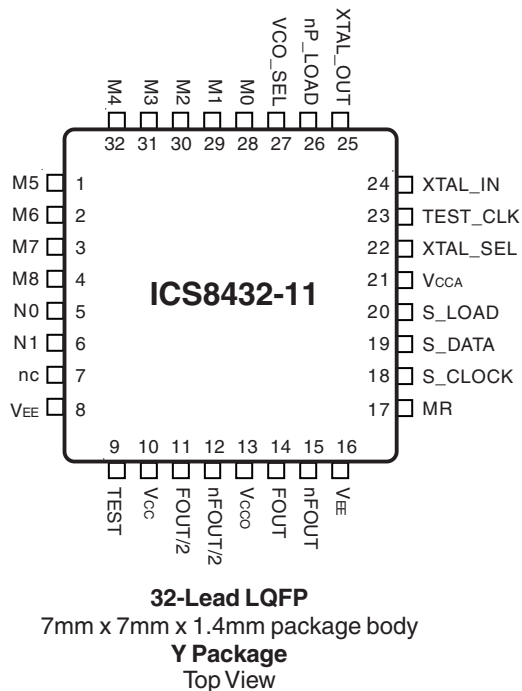
32-Lead LQFP
7mm x 7mm x 1.4mm package body
Y Package
Top View

FUNCTIONAL DESCRIPTION

NOTE: The functional description that follows describes operation using a 25MHz clock input. Valid PLL loop divider values for different input frequencies are defined in the Input Frequency Characteristics, Table 5, NOTE 1.

The ICS8432-11 features a fully integrated PLL and therefore requires no external components for setting the loop bandwidth. A differential clock input is used as the input to the ICS8432-11. This input is fed into the phase detector. A 25MHz clock input provides a 25MHz phase detector reference frequency. The VCO of the PLL operates over a range of 200MHz to 700MHz. The output of the M divider is also applied to the phase detector.

The phase detector and the M divider force the VCO output frequency to be M times the reference frequency by adjusting the VCO control voltage. Note, that for some values of M (either too high or too low), the PLL will not achieve lock. The output of the VCO is scaled by a divider prior to being sent to each of the LVPECL output buffers. The divider provides a 50% output duty cycle.

The programmable features of the ICS8432-11 support two input modes to program the PLL M divider and N output divider. The two input operational modes are parallel and serial. *Figure1* shows the timing diagram for each mode. In parallel mode, the nP_LOAD input is initially LOW. The data on inputs M0 through M8 and N0 and N1 is passed directly to the M divider and N output divider. On the LOW-to-HIGH transition of the nP_LOAD input, the data is latched and the M divider remains loaded until the next LOW transition on nP_LOAD or until a serial event occurs. As a result, the M and N bits can be hardwired to set the M divider and N output divider to a specific default state that will automatically occur during power-up. The TEST output is LOW when operating in the parallel input mode. The relationship between the VCO frequency, the input frequency and the M divider is defined as follows:

$$fVCO = fxtal \times M$$

The M value and the required values of M0 through M8 are shown in Table 3B, Programmable VCO Frequency Function Table. Valid M values for which the PLL will achieve lock are defined as $8 \leq M \leq 28$. The frequency out is defined as follows:

$$fOUT = \frac{fVCO}{N} = fxtal \times \frac{M}{N}$$

Serial operation occurs when nP_LOAD is HIGH and S_LOAD is LOW. The shift register is loaded by sampling the S_DATA bits with the rising edge of S_CLOCK. The contents of the shift register are loaded into the M divider and N output divider when S_LOAD transitions from LOW-to-HIGH. The M divide and N output divide values are latched on the HIGH-to-LOW transition of S_LOAD. If S_LOAD is held HIGH, data at the S_DATA input is passed directly to the M divider and N output divider on each rising edge of S_CLOCK. The serial mode can be used to program the M and N bits and test bits T1 and T0. The internal registers T0 and T1 determine the state of the TEST output as follows:

T1	T0	TEST Output
0	0	LOW
0	1	S_Data, Shift Register Input
1	0	Output of M divider
1	1	CMOS Fout/2
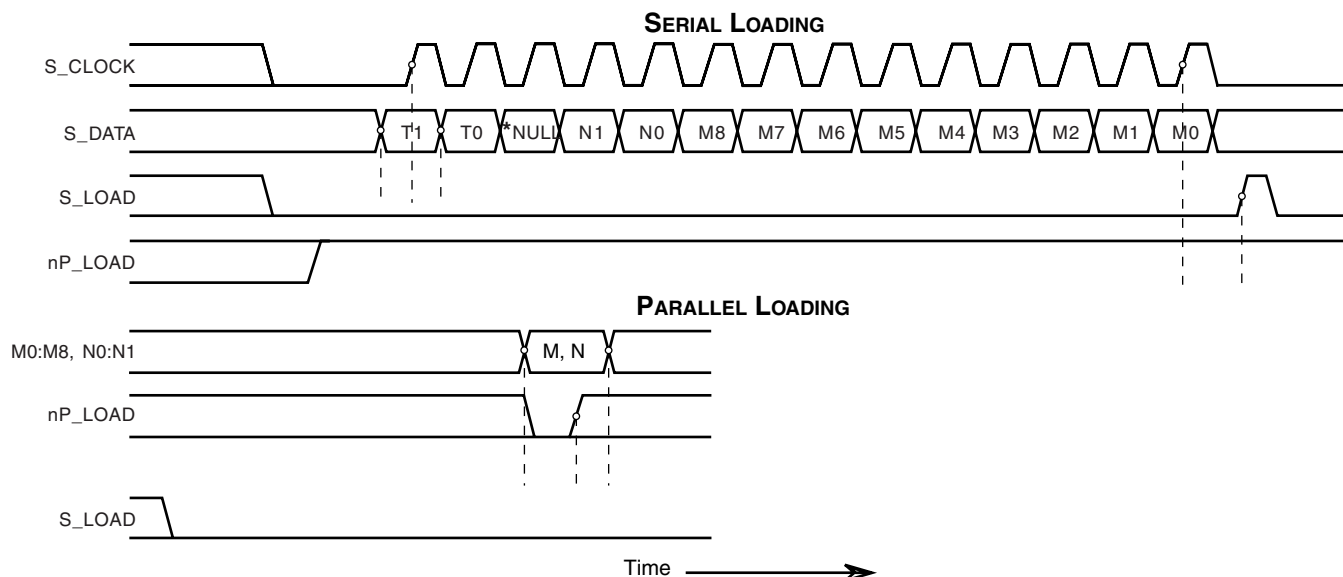
FIGURE 1. PARALLEL & SERIAL LOAD OPERATIONS

*NOTE: The NULL timing slot must be observed.

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TABLE 1. PIN DESCRIPTIONS

Number	Name	Type		Description
1	M5	Input	Pullup	M divider inputs. Data latched on LOW-to-HIGH transistion of nP_LOAD input. LVCMOS / LVTTL interface levels.
2, 3, 4, 28, 29, 30, 31, 32	M6, M7, M8, M0, M1, M2, M3, M4	Input	Pulldown	
5, 6	N0, N1	Input	Pulldown	Determines N output divider value as defined in Table 3C Function Table. LVCMOS / LVTTL interface levels.
7	nc	Unused		No connect.
8, 16	V_{EE}	Power		Negative supply pins.
9	TEST	Output		Test output which is ACTIVE in the serial mode of operation. Output driven LOW in parallel mode. LVCMOS interface levels.
10	V_{CC}	Power		Core supply pin.
11, 12	FOUT/2, nFOUT/2	Output		Half frequency differential output for the synthesizer. 3.3V LVPECL interface levels.
13	V_{CCO}	Power		Output supply pin.
14, 15	FOUT, nFOUT	Output		Differential output for the synthesizer. 3.3V LVPECL interface levels.
17	MR	Input	Pulldown	Active High Master Reset. When logic HIGH, the internal dividers are rset causing the true outputs (FOUTx) to go low and the inverted outputs (nFOUTx) to go high. When logic LOW, the internal dividers and the outputs are enabled. Assertion of MR does not affect loaded M, N, and T values. LVCMOS / LVTTL interface levels.
18	S_CLOCK	Input	Pulldown	Clocks in serial data present at S_DATA input into the shift register on the rising edge of S_CLOCK. LVCMOS / LVTTL interface levels.
19	S_DATA	Input	Pulldown	Shift register serial input. Data sampled on the rising edge of S_CLOCK. LVCMOS / LVTTL interface levels.
20	S_LOAD	Input	Pulldown	Controls transition of data from shift register into the dividers. LVCMOS / LVTTL interface levels.
21	V_{CCA}	Power		Analog supply pin.
22	XTAL_SEL	Input	Pullup	Selects between crystal or test inputs as the PLL reference source. LVCMOS / LVTTL interface levels. Selects XTAL inputs when HIGH. Selects TEST_CLK when LOW.
23	TEST_CLK	Input	Pulldown	Test clock input. LVCMOS / LVTTL interface levels.
24, 25	XTAL_IN, XTAL_OUT	Input		Crystal oscillator inputs. XTAL_IN is the input. XTAL_OUT is the output.
26	nP_LOAD	Input	Pulldown	Parallel load input. Determines when data present at M8:M0 is loaded into M divider, and when data present at N1:N0 sets the N output divider value. LVCMOS / LVTTL interface levels.
27	VCO_SEL	Input	Pullup	Determines whether synthesizer is in PLL or bypass mode. LVCMOS / LVTTL interface levels.

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

TABLE 2. PIN CHARACTERISTICS

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C_{IN}	Input Capacitance			4		pF
R_{PULLUP}	Input Pullup Resistor			51		kΩ
$R_{PULLDOWN}$	Input Pulldown Resistor			51		kΩ

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TABLE 3A. PARALLEL AND SERIAL MODES FUNCTION TABLE

MR	nP_LOAD	M	N	S_LOAD	S_CLOCK	S_DATA	Conditions
H	X	X	X	X	X	X	Reset. M and N counters reset.
L	L	Data	Data	X	X	X	Data on M and N inputs passed directly to the M divider. TEST output forced LOW.
L	↑	Data	Data	L	X	X	Data is latched into input registers and remains loaded until next LOW transition or until a serial event occurs.
L	H	X	X	L	↑	Data	Serial input mode. Shift register is loaded with data on S_DATA on each rising edge of S_CLOCK.
L	H	X	X	↑	L	Data	Contents of the shift register are passed to the M divider.
L	H	X	X	↓	L	Data	M divider and N output divider values are latched.
L	H	X	X	L	X	X	Parallel or serial input do not affect shift registers.
L	H	X	X	H	↑	Data	S_DATA passed directly to M divider as it is clocked.

NOTE: L = LOW
H = HIGH
X = Don't care
↑ = Rising edge transition
↓ = Falling edge transition

TABLE 3B. PROGRAMMABLE VCO FREQUENCY FUNCTION TABLE

VCO Frequency (MHz)	M Divide	256	128	64	32	16	8	4	2	1
		M8	M7	M6	M5	M4	M3	M2	M1	M0
200	8	0	0	0	0	0	1	0	0	0
225	9	0	0	0	0	0	1	0	0	1
250	10	0	0	0	0	0	1	0	1	0
275	11	0	0	0	0	0	1	0	1	1
•	•	•	•	•	•	•	•	•	•	•
•	•	•	•	•	•	•	•	•	•	•
650	26	0	0	0	0	1	1	0	1	0
675	27	0	0	0	0	1	1	0	1	1
700	28	0	0	0	0	1	1	1	0	0

NOTE 1: These M divide values and the resulting frequencies correspond to crystal or TEST_CLK input frequency of 25MHz.

TABLE 3C. PROGRAMMABLE OUTPUT DIVIDER FUNCTION TABLE

Inputs		N Divider Value	Output Frequency (MHz)			
			FOUT		FOUT/2	
N1	N0		Minimum	Maximum	Minimum	Maximum
0	0	1	200	700	125	350
0	1	2	100	350	62.5	175
1	0	4	50	175	31.25	87.5
1	1	8	25	87.5	15.625	43.75

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Absolute Maximum Ratings

Supply Voltage, V_{CC}	4.6V
Inputs, V_I	-0.5V to V_{CC} + 0.5 V
Outputs, I_O	
Continuous Current	50mA
Surge Current	100mA
Package Thermal Impedance, θ_{JA}	47.9°C/W (0 lfpm)
Storage Temperature, T_{STG}	-65°C to 150°C

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Table 4A. Power Supply DC Characteristics, $V_{CC} = V_{CCA} = V_{CCO} = 3.3V\pm5\%$, $T_A = 0°C$ to $70°C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{CC}	Positive Supply Voltage		3.135	3.3	3.465	V
V_{CCA}	Analog Supply Voltage		3.135	3.3	3.465	V
V_{CCO}	Output Supply Voltage		3.135	3.3	3.465	V
I_{EE}	Power Supply Current				110	mA
I_{CCA}	Analog Supply Current				15	mA

Table 4B. LVCMOS / LVTTL DC Characteristics, $V_{CC} = V_{CCA} = V_{CCO} = 3.3V\pm5\%$, $T_A = 0°C$ to $70°C$

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V_{IH}	Input High Voltage			2		V_{CC} + 0.3	V
V_{IL}	Input Low Voltage			-0.3		0.8	V
I_{IH}	Input High Current	M0-M4, M6-M8, N0, N1, MR, S_CLOCK, TEST_CLK, S_DATA, S_LOAD, nP_LOAD	$V_{CC} = V_{IN} = 3.465V$			150	µA
		M5, XTAL_SEL, VCO_SEL	$V_{CC} = V_{IN} = 3.465V$			5	µA
I_{IL}	Input Low Current	M0-M4, M6-M8, N0, N1, MR, S_CLOCK, TEST_CLK, S_DATA, S_LOAD, nP_LOAD	$V_{CC} = 3.465V$, $V_{IN} = 0V$	-5			µA
		M5, XTAL_SEL, VCO_SEL	$V_{CC} = 3.465V$, $V_{IN} = 0V$	-150			µA
V_{OH}	Output High Voltage		TEST; NOTE 1	2.6			V
V_{OL}	Output Low Voltage		TEST; NOTE 1			0.5	V

NOTE 1: Outputs terminated with 50Ω to V_{CCO}/2. See "Parameter Measurement Information" section, "3.3V Output Load Test Circuit" figure.

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TABLE 4C. LVPECL DC Characteristics, $V_{CC} = V_{CCA} = V_{CCO} = 3.3V\pm5\%$, $T_A = 0°C$ to $70°C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{OH}	Output High Voltage; NOTE 1		V_{CCO} - 1.4		V_{CCO} - 0.9	V
V_{OL}	Output Low Voltage; NOTE 1		V_{CCO} - 2.0		V_{CCO} - 1.7	V
V_{SWING}	Peak-to-Peak Output Voltage Swing		0.6		1.0	V

NOTE 1: Outputs terminated with 50 Ω to V_{CCO} - 2V.

TABLE 5. Input Frequency Characteristics, $V_{CC} = V_{CCA} = V_{CCO} = 3.3V\pm5\%$, $T_A = 0°C$ to $70°C$

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f_{IN}	Input Frequency	TEST_CLK; NOTE 1		12		25	MHz
		XTAL_IN, XTAL_OUT; NOTE 1		12		25	MHz
		S_CLOCK				TBD	MHz

NOTE 1: For the input crystal and TEST_CLK frequency range, the M value must be set for the VCO to operate within the 200MHz to 700MHz range. Using the minimum input frequency of 12MHz, valid values of M are $17 \le M \le 58$. Using the maximum frequency of 25MHz, valid values of M are $8 \le M \le 28$.

TABLE 6. Crystal Characteristics

Parameter	Test Conditions	Minimum	Typical	Maximum	Units
Mode of Oscillation			Fundamental		
Frequency		12		25	MHz
Equivalent Series Resistance (ESR)				70	Ω
Shunt Capacitance				7	pF
Drive Level				1	mW

**TABLE 7. AC Characteristics,** $V_{CC} = V_{CCA} = V_{CCO} = 3.3V\pm5\%$, $T_A = 0°C$ to $70°C$

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
F_{OUT}	Output Frequency			25		700	MHz
tjit(cc)	Cycle-to-Cycle Jitter; NOTE 1, 3					25	ps
tjit(per)	Period Jitter, RMS; NOTE 1, 3					TBD	ps
$t$sk(o)	Output Skew; NOTE 2, 3					TBD	ps
t_R	Output Rise Time		20% to 80% @ 50MHz	300		700	ps
t_F	Output Fall Time		20% to 80% @ 50MHz	300		700	ps
t_S	Setup Time	M, N to nP_LOAD		5			ns
		S_DATA to S_CLOCK		5			ns
		S_CLOCK to S_LOAD		5			ns
t_H	Hold Time	M, N to nP_LOAD		5			ns
		S_DATA to S_CLOCK		5			ns
		S_CLOCK to S_LOAD		5			ns
odc	Output Duty Cycle			47		53	%
t_{LOCK}	PLL Lock Time					10	ms

All parameters measured at 500MHz unless noted otherwise.
NOTE 1: Jitter performance using XTAL inputs.
NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions.
Measured at the output differential cross points.
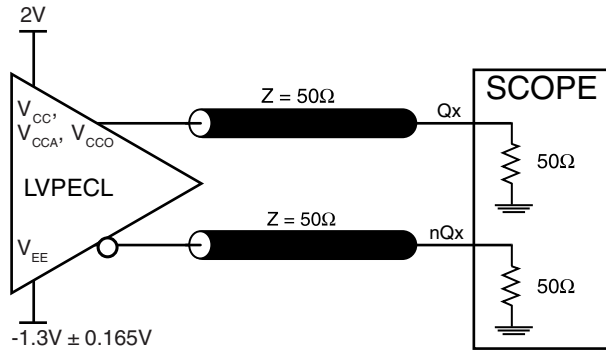NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.
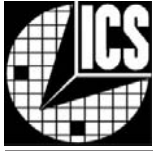
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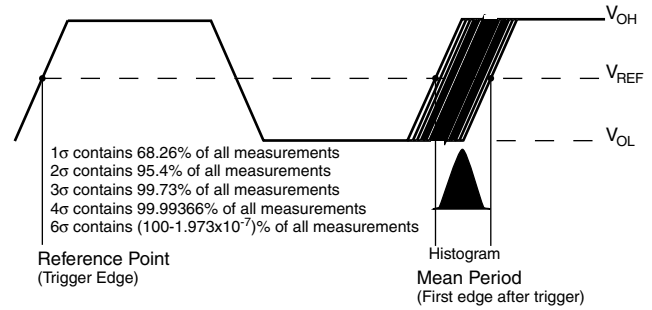700MHz/350MHz, Low Phase Noise,
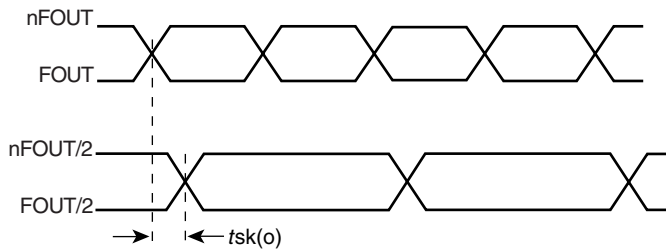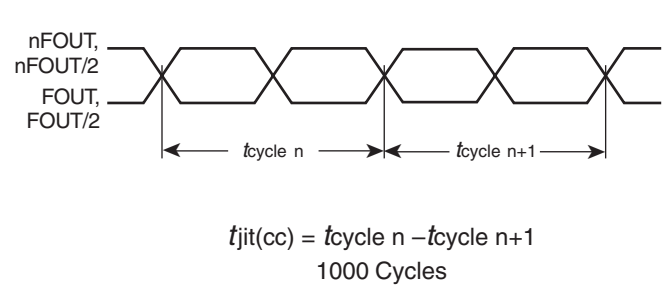Crystal-to- 3.3V LVPECL Frequency Synthesizer

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Parameter Measurement Information

2V

V_{CC}, V_{CCA}, V_{CCO}

LVPECL

V_{EE}

$Z = 50\Omega$ Qx

$Z = 50\Omega$ nQx

SCOPE

50Ω

50Ω

-1.3V ± 0.165V

3.3V Output Load AC Test Circuit

V_{OH}

V_{REF}

V_{OL}

1σ contains 68.26% of all measurements
2σ contains 95.4% of all measurements
3σ contains 99.73% of all measurements
4σ contains 99.99366% of all measurements
6σ contains (100-1.973x10^{-7})% of all measurements

Reference Point
(Trigger Edge)

Histogram
Mean Period
(First edge after trigger)

Period Jitter

nFOUT

FOUT

nFOUT/2

FOUT/2

$t$sk(o)

Output Skew

nFOUT,
nFOUT/2

FOUT,
FOUT/2

$t$cycle n $t$cycle n+1

$t$jit(cc) = $t$cycle n − $t$cycle n+1
1000 Cycles

Cycle-to-Cycle Jitter

nFOUT,
nFOUT/2

FOUT,
FOUT/2

t_{PW}

t_{PERIOD}

$$odc = \frac{t_{PW}}{t_{PERIOD}} \times 100\%$$

Ouput Duty Cycle/Output Pulse Width/Period

80%   80%

Clock
Outputs   20%   20%

V_{SWING}

t_R t_F
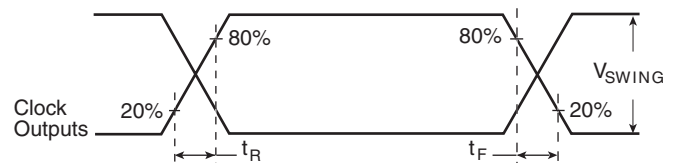
Output Rise/Fall Time

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APPLICATIONS

STORAGE AREA NETWORKS

A variety of technologies are used for interconnection of the elements within a SAN. The tables below list the common application frequencies as well as the ICS8432-11 configurations used to generate the appropriate frequency.

Table 8. COMMON SANS APPLICATIONS FREQUENCIES

Interconnect Technology	Clock Rate	Reference Frequency to SERDES (MHz)	Crystal Frequency (MHz)
Gigabit Ethernet	1.25 GHz	125, 250, 156.25	25, 19.53125
Fibre Channel	FC1 1.0625 GHz FC2 2.1250 GHz	106.25, 53.125, 132.8125	16.6015625, 25
Infiniband	2.5 GHz	125, 250	25

Table 9. CONFIGURATION DETAILS FOR SANS APPLICATIONS

Interconnect Technology	Crystal Frequency (MHz)	ICS8432-11 Output Frequency to SERDES (MHz)	ICS8432-11 M & N Settings										
			M8	M7	M6	M5	M4	M3	M2	M1	M0	N1	N0
Gigabit Ethernet	25	125	0	0	0	0	1	0	1	0	0	1	0
	25	250	0	0	0	0	1	0	1	0	0	0	1
	25	156.25	0	0	0	0	1	1	0	0	1	1	0
	19.53125	156.25	0	0	0	1	0	0	0	0	0	1	0
Fiber Channel 1	25	53.125	0	0	0	0	1	0	0	0	1	1	1
	25	106.25	0	0	0	0	1	0	0	0	1	1	0
Fiber Channel 2	16.6015625	132.8125	0	0	0	1	0	0	0	0	0	1	0
Infiniband	25	125	0	0	0	0	1	0	1	0	0	1	0
	25	250	0	0	0	0	1	0	1	0	0	0	1

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POWER SUPPLY FILTERING TECHNIQUES

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. The ICS8432-11 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL. V_{CC}, V_{CCA}, and V_{CCO} should be individually connected to the power supply plane through vias, and bypass capacitors should be used for each pin. To achieve optimum jitter performance, power supply isolation is required. *Figure 2* illustrates how a 10Ω resistor along with a 10µF and a .01µF bypass capacitor should be connected to each V_{CCA} pin.
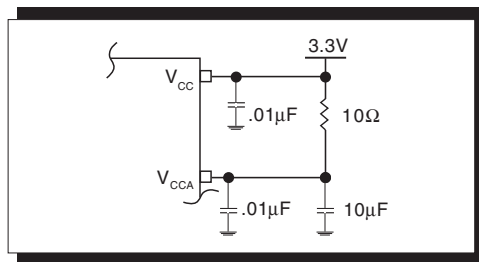

FIGURE 2. POWER SUPPLY FILTERING

TERMINATION FOR LVPECL OUTPUTS

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

FOUT and nFOUT are low impedance follower outputs that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are designed to drive 50Ω transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. *Figures 3A and 3B* show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.
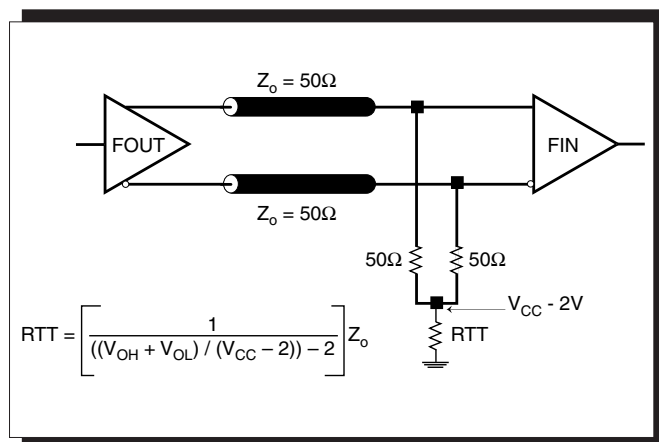
FIGURE 3A. LVPECL OUTPUT TERMINATION
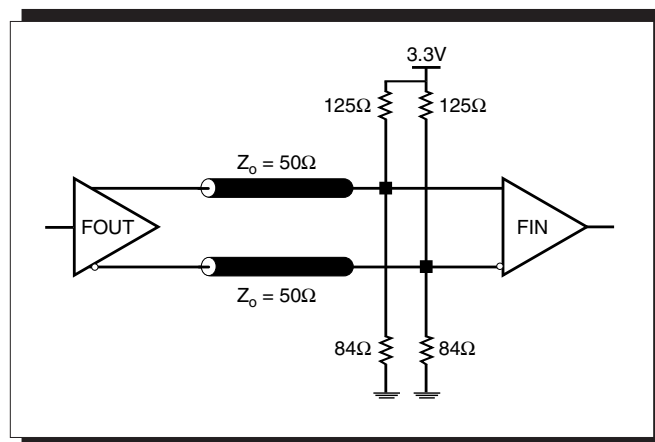
FIGURE 3B. LVPECL OUTPUT TERMINATION
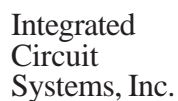
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LAYOUT GUIDELINE

The schematic of the ICS8432-11 layout example used in this layout guideline is shown in *Figure 4A.* The ICS8432-11 recommended PCB board layout for this example is shown in *Figure 4B.* This layout example is used as a general guideline. The lay-out in the actual system will depend on the selected component types, the density of the components, the density of the traces, and the stacking of the P.C. board.
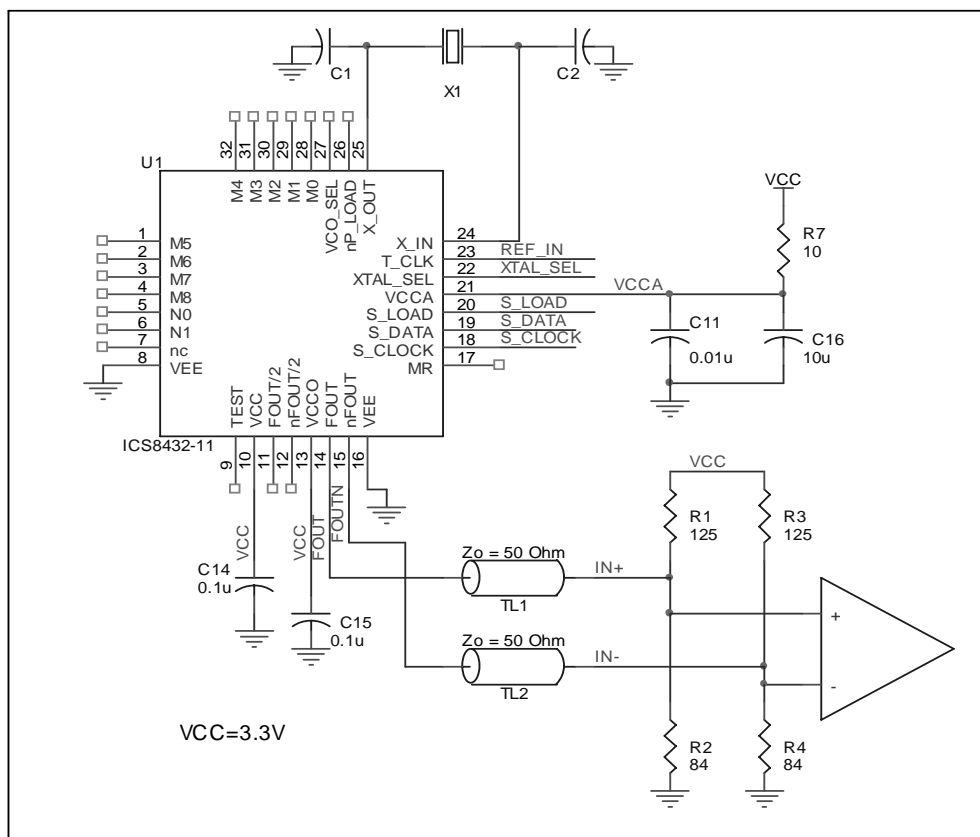
FIGURE 4A. SCHEMATIC OF RECOMMENDED LAYOUT

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The following component footprints are used in this layout example:

All the resistors and capacitors are size 0603.

POWER AND GROUNDING

Place the decoupling capacitors C14 and C15, as close as possible to the power pins. If space allows, placement of the decoupling capacitor on the component side is preferred. This can reduce unwanted inductance between the decoupling capacitor and the power pin caused by the via.

Maximize the power and ground pad sizes and number of vias capacitors. This can reduce the inductance between the power and ground planes and the component power and ground pins.

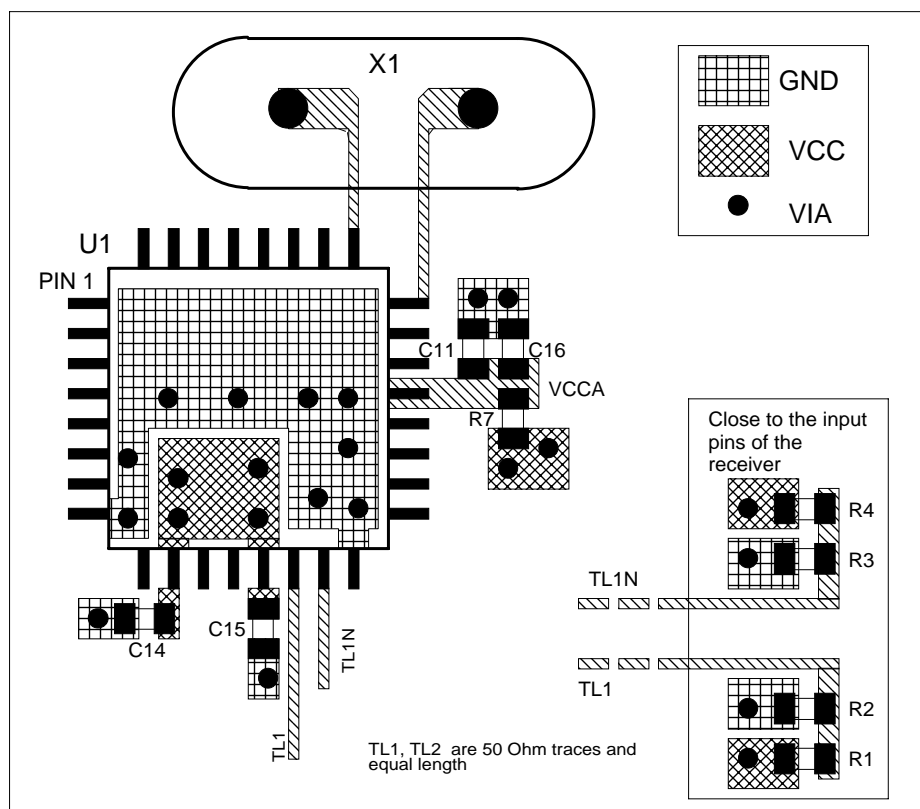The RC filter consisting of R7, C11, and C16 should be placed as close to the V_{CCA} pin as possible.

CLOCK TRACES AND TERMINATION

Poor signal integrity can degrade the system performance or cause system failure. In synchronous high-speed digital systems, the clock signal is less tolerant to poor signal integrity than other signals. Any ringing on the rising or falling edge or excessive ring back can cause system failure. The shape of the trace and the trace delay might be restricted by the available space on the board and the component location. While routing the traces, the clock signal traces should be routed first and should be locked prior to routing other signal traces.

• The differential 50Ω output traces should have same length.

• Avoid sharp angles on the clock trace. Sharp angle turns cause the characteristic impedance to change on the transmission lines.

• Keep the clock traces on the same layer. Whenever possible, avoid placing vias on the clock traces. Placement of vias on the traces can affect the trace characteristic impedance and hence degrade signal integrity.

• To prevent cross talk, avoid routing other signal traces in parallel with the clock traces. If running parallel traces is unavoidable, allow a spearation of at least three trace widths between the differential clock trace and the other signal trace.

• Make sure no other signal traces are routed between the clock trace pair.

• The matching termination resistors should be located as close to the receiver input pins as possible.

CRYSTAL

The crystal X1 should be located as close as possible to the pins 24 (XTAL_IN) and 25 (XTAL_OUT). The trace length between the X1 and U1 should be kept to a minimum to avoid unwanted parasitic inductance and capacitance. Other signal traces should not be routed near the crystal traces.

FIGURE 4B. PCB BOARD LAYOUT FOR ICS8432-11

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POWER CONSIDERATIONS

This section provides information on power dissipation and junction temperature for the ICS8432-11.
Equations and example calculations are also provided.

1. Power Dissipation.
The total power dissipation for the ICS8432-11 is the sum of the core power plus the power dissipated in the load(s).
The following is the power dissipation for V_{CC} = 3.3V + 5% = 3.465V, which gives worst case results.
NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core)$_{MAX}$ = V_{CC_MAX} * I_{EE_MAX} = 3.465V * 110mA = **381.2mW**

- Power (outputs)$_{MAX}$ = **30mW/Loaded Output pair**
  If all outputs are loaded, the total power is 2 * 30mW = **60mW**

  Total Power$_{\_MAX}$ (3.465V, with all outputs switching) = 381.2mW + 60.4mW = **441.2mW**

2. Junction Temperature.
Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad and directly affects the reliability of the device. The maximum recommended junction temperature for HiPerClockS™ devices is 125°C.

The equation for Tj is as follows: Tj = θ_{JA} * Pd_total + T_A

Tj = Junction Temperature

θ_{JA} = Junction-to-Ambient Thermal Resistance

Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)

T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming a moderate air flow of 200 linear feet per minute and a multi-layer board, the appropriate value is 42.1°C/W per Table 10 below.

Therefore, Tj for an ambient temperature of 70°C with all outputs switching is:
70°C + 0.441W * 42.1°C/W = 88.6°C. This is well below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow, and the type of board (single layer or multi-layer).

TABLE 10. THERMAL RESISTANCE θ_{JA} FOR 32-PIN LQFP, FORCED CONVECTION

θ_{JA} by Velocity (Linear Feet per Minute)		
	0	200	500
Single-Layer PCB, JEDEC Standard Test Boards	67.8°C/W	55.9°C/W	50.1°C/W
Multi-Layer PCB, JEDEC Standard Test Boards	47.9°C/W	42.1°C/W	39.4°C/W

NOTE: Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.

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3. Calculations and Equations.

The purpose of this section is to derive the power dissipated into the load.

LVPECL output driver circuit and termination are shown in *Figure 5.*

FIGURE 5. LVPECL DRIVER CIRCUIT AND TERMINATION
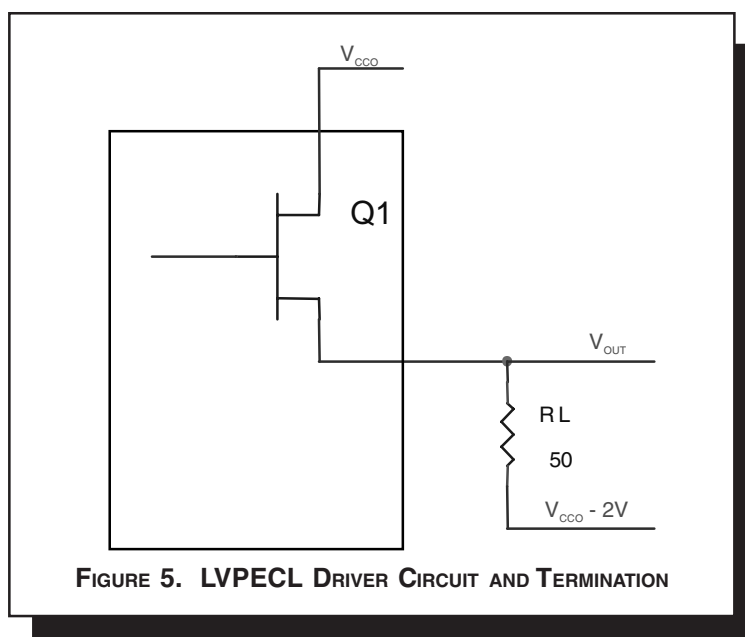
To calculate worst case power dissipation into the load, use the following equations which assume a 50Ω load, and a termination voltage of V_{CCO} - 2V.

- For logic high, $V_{OUT} = V_{OH\_MAX} = \mathbf{V_{CCO\_MAX} - 1.0V}$

  $(V_{CCO\_MAX} - V_{OH\_MAX}) = \mathbf{1.0V}$

- For logic low, $V_{OUT} = V_{OL\_MAX} = \mathbf{V_{CCO\_MAX} - 1.7V}$

  $(V_{CCO\_MAX} - V_{OL\_MAX}) = \mathbf{1.7V}$

Pd_H is power dissipation when the output drives high.
Pd_L is the power dissipation when the output drives low.

$Pd\_H = [(V_{OH\_MAX} - (V_{CCO\_MAX} - 2V))/R_L] * (V_{CCO\_MAX} - V_{OH\_MAX}) = [(2V - (V_{CCO\_MAX} - V_{OH\_MAX}))/R_L] * (V_{CCO\_MAX} - V_{OH\_MAX}) =$
$[(2V - 1V)/50Ω] * 1V = \mathbf{20.0mW}$

$Pd\_L = [(V_{OL\_MAX} - (V_{CCO\_MAX} - 2V))/R_L] * (V_{CCO\_MAX} - V_{OL\_MAX}) = [(2V - (V_{CCO\_MAX} - V_{OL\_MAX}))/R_L] * (V_{CCO\_MAX} - V_{OL\_MAX}) =$
$[(2V - 1.7V)/50Ω] * 1.7V = \mathbf{10.2mW}$

Total Power Dissipation per output pair = Pd_H + Pd_L = **30.2mW**

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RELIABILITY INFORMATION

TABLE 11. θ_{JA} VS. AIR FLOW TABLE FOR 32 LEAD LQFP

θ_{JA} by Velocity (Linear Feet per Minute)			
	0	**200**	**500**
Single-Layer PCB, JEDEC Standard Test Boards	67.8°C/W	55.9°C/W	50.1°C/W
Multi-Layer PCB, JEDEC Standard Test Boards	47.9°C/W	42.1°C/W	39.4°C/W

NOTE: Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.

TRANSISTOR COUNT

The transistor count for ICS8432-11 is: 3765

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Package Outline - Y Suffix for 32 Lead LQFP
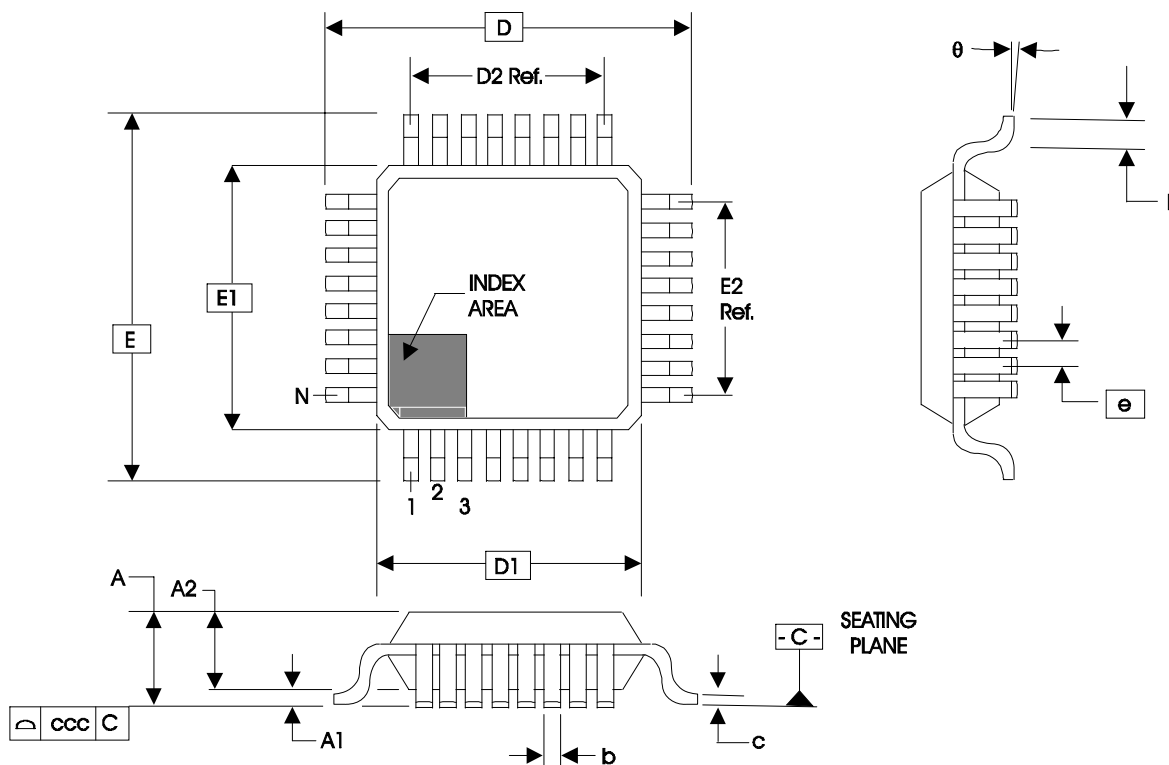
Table 12. Package Dimensions

SYMBOL	BBA		
	MINIMUM	NOMINAL	MAXIMUM
JEDEC VARIATION ALL DIMENSIONS IN MILLIMETERS			
N	32		
A	--	--	1.60
A1	0.05	--	0.15
A2	1.35	1.40	1.45
b	0.30	0.37	0.45
c	0.09	--	0.20
D	9.00 BASIC		
D1	7.00 BASIC		
D2	5.60 Ref.		
E	9.00 BASIC		
E1	7.00 BASIC		
E2	5.60 Ref.		
e	0.80 BASIC		
L	0.45	0.60	0.75
θ	0°	--	7°
ccc	--	--	0.10

Reference Document: JEDEC Publication 95, MS-026

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TABLE 13. ORDERING INFORMATION

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
ICS8432CY-11	ICS8432CY-11	32 Lead LQFP	tray	0°C to 70°C
ICS8430CY-11T	ICS8432CY-11	32 Lead LQFP	1000 tape & reel	0°C to 70°C